

Power MOSFET

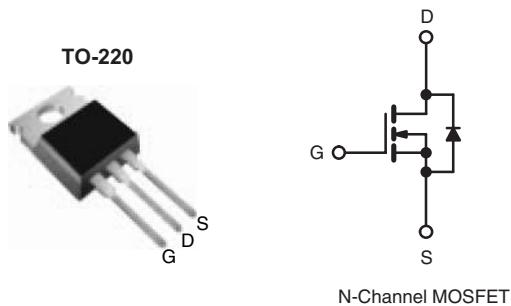
| PRODUCT SUMMARY | |
|---------------------------|---------------------|
| V_{DS} (V) | 600 |
| $R_{DS(on)}$ (Ω) | $V_{GS} = 10$ V 1.2 |
| Q_g (Max.) (nC) | 60 |
| Q_{gs} (nC) | 8.3 |
| Q_{gd} (nC) | 30 |
| Configuration | Single |

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Parallelizing
- Simple Drive Requirements
- Lead (Pb)-free Available



RoHS*
COMPLIANT



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION

| | |
|----------------|---------------------------|
| Package | TO-220 |
| Lead (Pb)-free | IRFBC40PbF SiHFBC40-E3 |
| SnPb | IRFBC40 SiHFBC40 |

ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted

| PARAMETER | SYMBOL | LIMIT | UNIT |
|--|------------------|------------------|----------|
| Drain-Source Voltage | V_{DS} | 600 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | |
| Continuous Drain Current | I_D | 6.2 | A |
| | | 3.9 | |
| Pulsed Drain Current ^a | I_{DM} | 25 | |
| Linear Derating Factor | | 1.0 | W/°C |
| Single Pulse Avalanche Energy ^b | E_{AS} | 570 | mJ |
| Repetitive Avalanche Current ^a | I_{AR} | 6.2 | A |
| Repetitive Avalanche Energy ^a | E_{AR} | 13 | mJ |
| Maximum Power Dissipation | P_D | 125 | W |
| Peak Diode Recovery dV/dt ^c | dV/dt | 3.0 | V/ns |
| Operating Junction and Storage Temperature Range | T_J, T_{stg} | - 55 to + 150 | °C |
| Soldering Recommendations (Peak Temperature) | for 10 s | 300 ^d | |
| Mounting Torque | 6-32 or M3 screw | 10 | lbf · in |
| | | 1.1 | N · m |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, $L = 27$ mH, $R_G = 25 \Omega$, $I_{AS} = 6.2$ A (see fig. 12).

c. $I_{SD} \leq 6.2$ A, $dI/dt \leq 80$ A/ μ s, $V_{DD} \leq V_{DS}$, $T_J \leq 150$ °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

THERMAL RESISTANCE RATINGS

| PARAMETER | SYMBOL | TYP. | MAX. | UNIT |
|-------------------------------------|------------|------|------|-----------------------------|
| Maximum Junction-to-Ambient | R_{thJA} | - | 62 | $^{\circ}\text{C}/\text{W}$ |
| Case-to-Sink, Flat, Greased Surface | R_{thCS} | 0.50 | - | |
| Maximum Junction-to-Case (Drain) | R_{thJC} | - | 1.0 | |

SPECIFICATIONS $T_J = 25 \text{ }^{\circ}\text{C}$, unless otherwise noted

| PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT | |
|--|---------------------|---|--|------|-----------|-----------------------------|----|
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0 \text{ V}$, $I_D = 250 \mu\text{A}$ | 600 | - | - | V | |
| V_{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | Reference to $25 \text{ }^{\circ}\text{C}$, $I_D = 1 \text{ mA}$ | - | 0.7 | - | $\text{V}/^{\circ}\text{C}$ | |
| Gate-Source Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$ | 2.0 | - | 4.0 | V | |
| Gate-Source Leakage | I_{GSS} | $V_{GS} = \pm 20 \text{ V}$ | - | - | ± 100 | nA | |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = 600 \text{ V}$, $V_{GS} = 0 \text{ V}$ | - | - | 100 | μA | |
| | | $V_{DS} = 480 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_J = 125 \text{ }^{\circ}\text{C}$ | - | - | 500 | | |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS} = 10 \text{ V}$ | $I_D = 3.7 \text{ A}^b$ | - | - | Ω | |
| Forward Transconductance | g_{fs} | $V_{DS} = 100 \text{ V}$ | $I_D = 3.7 \text{ A}^b$ | 4.7 | - | - | |
| Dynamic | | | | | | | |
| Input Capacitance | C_{iss} | $V_{GS} = 0 \text{ V}$, $V_{DS} = 25 \text{ V}$, $f = 1.0 \text{ MHz}$, see fig. 5 | - | 1300 | - | pF | |
| Output Capacitance | C_{oss} | | - | 160 | - | | |
| Reverse Transfer Capacitance | C_{rss} | | - | 30 | - | | |
| Total Gate Charge | Q_g | $V_{GS} = 10 \text{ V}$ | $I_D = 6.2 \text{ A}$, $V_{DS} = 360 \text{ V}$, see fig. 6 and 13 ^b | - | - | 60 | |
| Gate-Source Charge | Q_{gs} | | | - | - | 8.3 | |
| Gate-Drain Charge | Q_{gd} | | | - | - | 30 | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = 300 \text{ V}$, $I_D = 6.2 \text{ A}$, $R_G = 9.1 \Omega$, $R_D = 47 \Omega$, see fig. 10 ^b | - | 13 | - | ns | |
| Rise Time | t_r | | - | 18 | - | | |
| Turn-Off Delay Time | $t_{d(off)}$ | | - | 55 | - | | |
| Fall Time | t_f | | - | 20 | - | | |
| Internal Drain Inductance | L_D | Between lead, 6 mm (0.25") from package and center of die contact | | - | 4.5 | - | nH |
| Internal Source Inductance | L_S | | | - | 7.5 | - | |
| Drain-Source Body Diode Characteristics | | | | | | | |
| Continuous Source-Drain Diode Current | I_S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 6.2 | A |
| Pulsed Diode Forward Current ^a | I_{SM} | | | - | - | 25 | |
| Body Diode Voltage | V_{SD} | $T_J = 25 \text{ }^{\circ}\text{C}$, $I_S = 6.2 \text{ A}$, $V_{GS} = 0 \text{ V}^b$ | - | - | 1.5 | V | |
| Body Diode Reverse Recovery Time | t_{rr} | $T_J = 25 \text{ }^{\circ}\text{C}$, $I_F = 6.2 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}^b$ | - | 450 | 940 | ns | |
| Body Diode Reverse Recovery Charge | Q_{rr} | | - | 3.8 | 7.9 | μC | |
| Forward Turn-On Time | t_{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | | | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width $\leq 300 \mu\text{s}$; duty cycle $\leq 2 \%$.

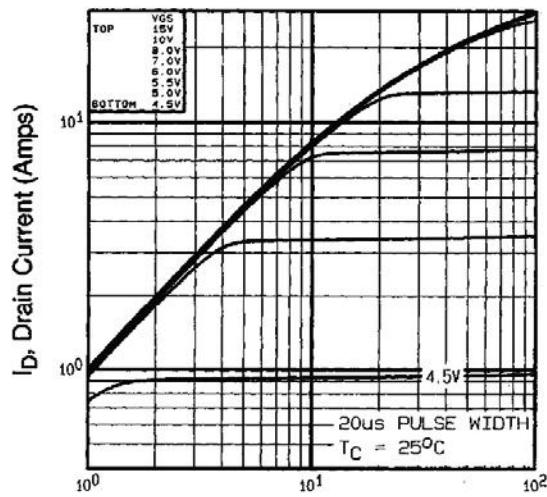
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

V_{DS}, Drain-to-Source Voltage (volts)

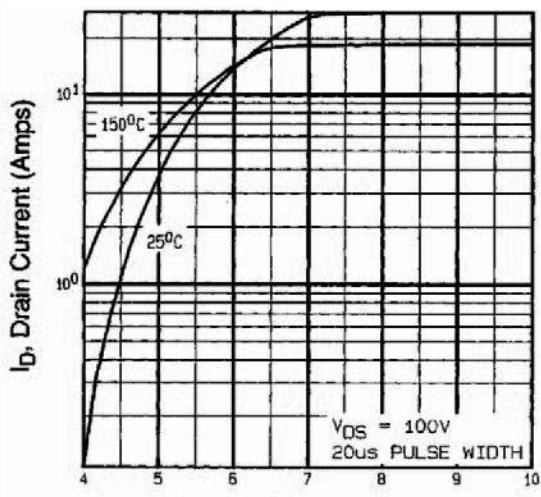
Fig. 1 - Typical Output Characteristics, $T_C = 25^\circ\text{C}$

V_{GS}, Gate-to-Source Voltage (volts)

Fig. 3 - Typical Transfer Characteristics

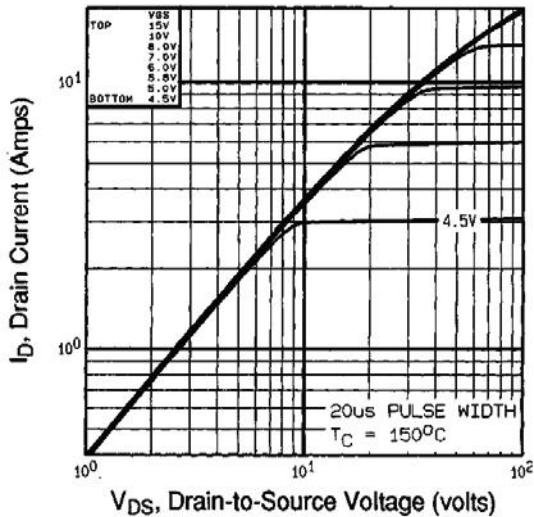

V_{DS}, Drain-to-Source Voltage (volts)

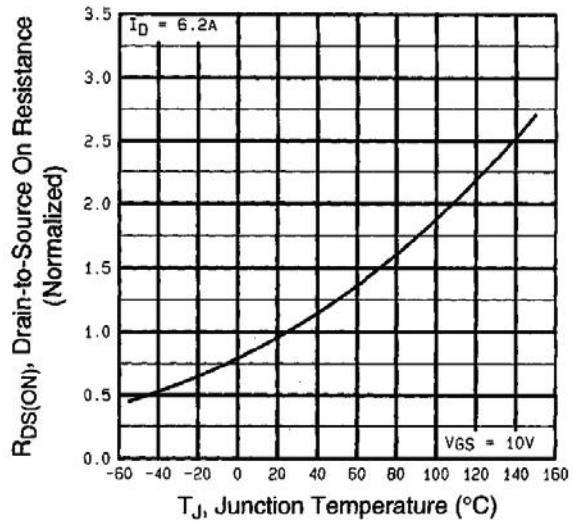
Fig. 2 - Typical Output Characteristics, $T_C = 150^\circ\text{C}$


Fig. 4 - Normalized On-Resistance vs. Temperature

IRFBC40, SiHFBC40



Vishay Siliconix

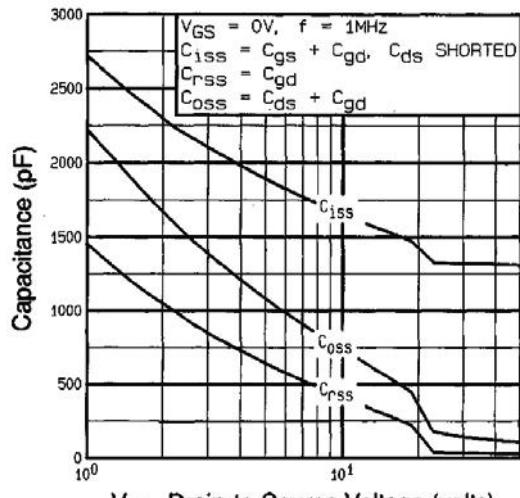


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

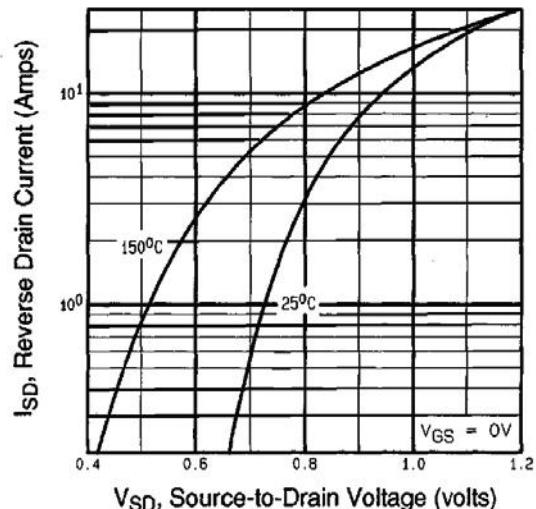


Fig. 7 - Typical Source-Drain Diode Forward Voltage

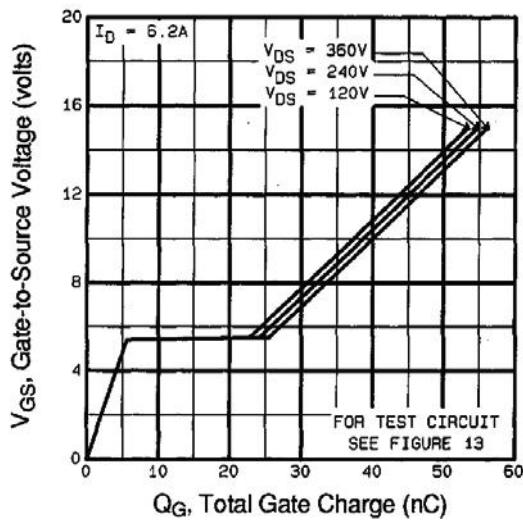


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

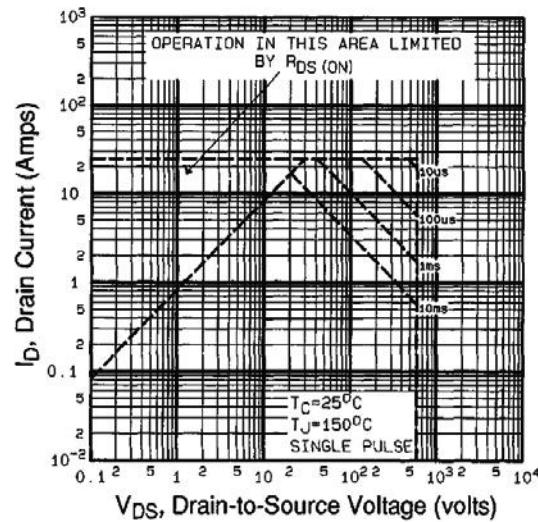


Fig. 8 - Maximum Safe Operating Area

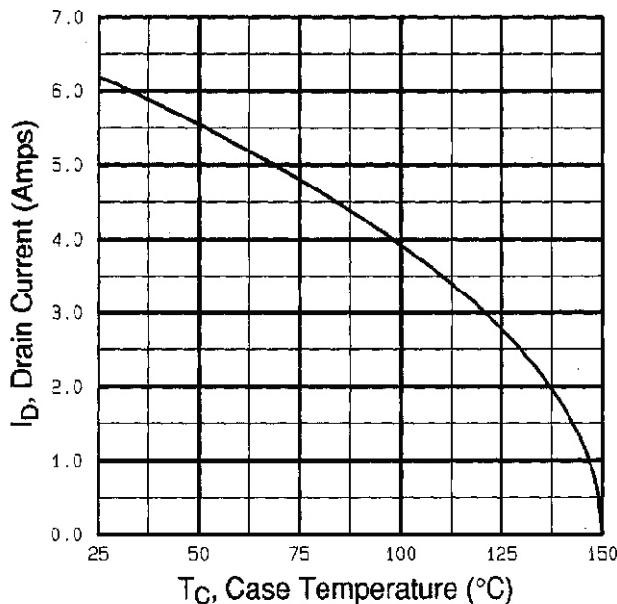


Fig. 9 - Maximum Drain Current vs. Case Temperature

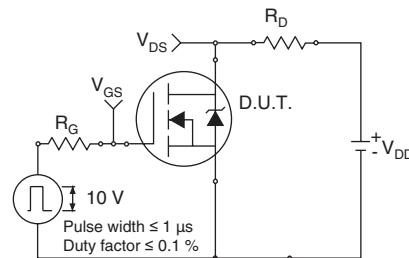


Fig. 10a - Switching Time Test Circuit

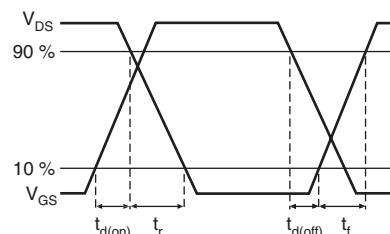


Fig. 10b - Switching Time Waveforms

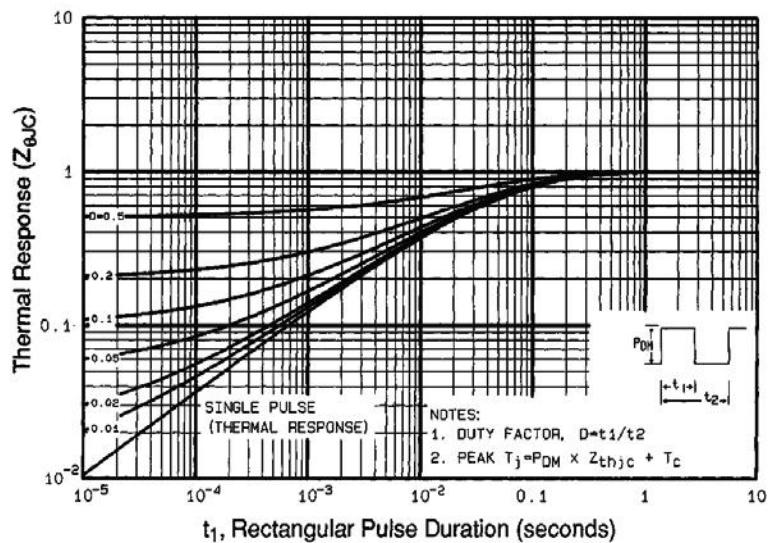


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

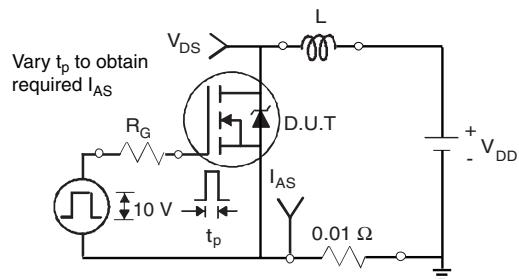


Fig. 12a - Unclamped Inductive Test Circuit

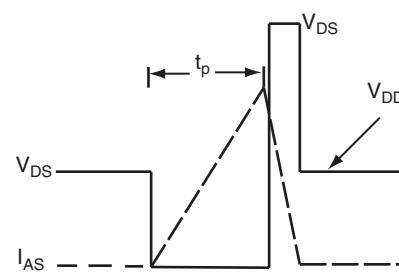


Fig. 12b - Unclamped Inductive Waveforms

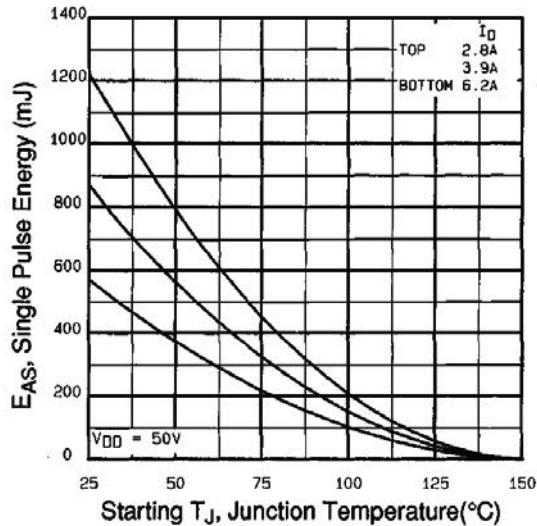


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

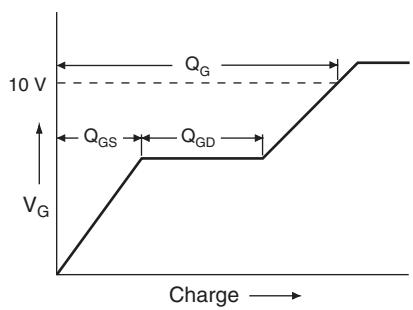


Fig. 13a - Basic Gate Charge Waveform

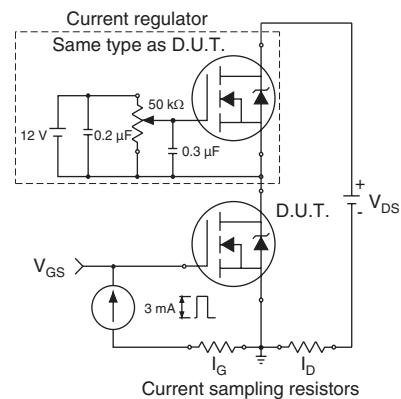
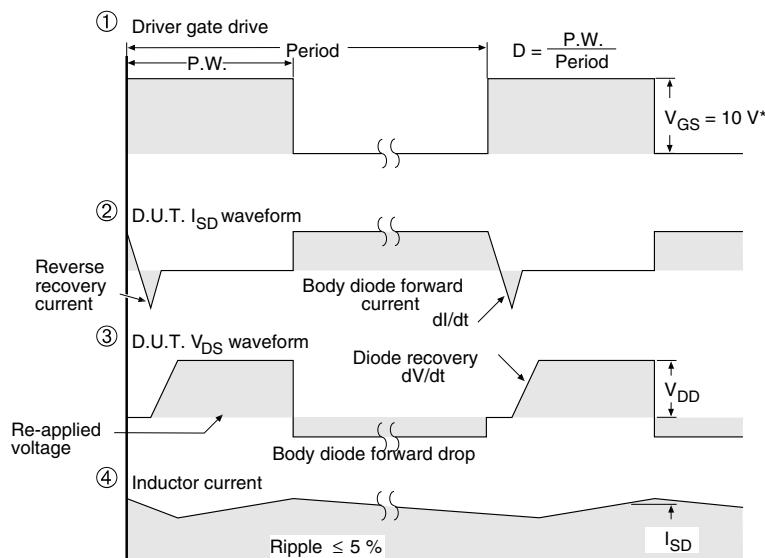
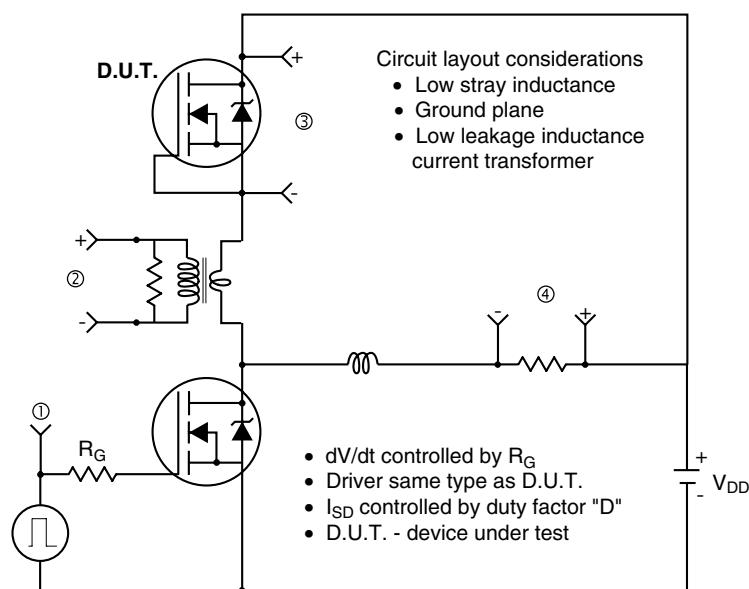


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



* $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel

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